# 2SB1219, 2SB1219A

## Silicon PNP epitaxial planar type

For general amplification

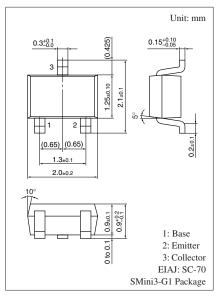
Complementary to 2SD1820 and 2SD1820A

#### ■ Features

- Large collector current I<sub>C</sub>
- S-Mini type package, allowing downsizing of the equipment and automatic insertion through the tape packing and the magazine packing.

### ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage	2SB1219	V <sub>CBO</sub>	-30	V
(Emitter open)	2SB1219A		-60	
Collector-emitter voltage	2SB1219	V <sub>CEO</sub>	-25	V
(Base open)	2SB1219A		-50	
Emitter-base voltage (Coll	V <sub>EBO</sub>	-5	V	
Collector current	$I_C$	-500	mA	
Peak collector current	$I_{CP}$	-1	A	
Collector power dissipation	P <sub>C</sub>	150	mW	
Junction temperature	$T_{j}$	150	°C	
Storage temperature	T <sub>stg</sub>	-55 to +150	°C	



#### Marking Symbol:

• 2SB1219: C

• 2SB1219A: D

### ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage	2SB1219	V <sub>CBO</sub>	$I_{\rm C} = -10 \ \mu A, \ I_{\rm E} = 0$	-30			V
(Emitter open)	2SB1219A			-60			
Collector-emitter voltage	2SB1219	V <sub>CEO</sub>	$I_C = -2 \text{ mA}, I_B = 0$	-25			V
(Base open)	2SB1219A			-50			
Emitter-base voltage (Collector open)		$V_{EBO}$	$I_E = -10 \ \mu A, I_C = 0$	-5			V
Collector-base cutoff current (Emitter open)		$I_{CBO}$	$V_{CB} = -20 \text{ V}, I_{E} = 0$			- 0.1	μΑ
Forward current transfer ratio *1		h <sub>FE1</sub> *2	$V_{CE} = -10 \text{ V}, I_{C} = -150 \text{ mA}$	85		340	_
		h <sub>FE2</sub>	$V_{CE} = -10 \text{ V}, I_{C} = -500 \text{ mA}$	40			
Collector-emitter saturation voltage *1		V <sub>CE(sat)</sub>	$I_C = -300 \text{ mA}, I_B = -30 \text{ mA}$		- 0.35	- 0.60	V
Base-emitter saturation voltage *1		V <sub>BE(sat)</sub>	$I_C = -300 \text{ mA}, I_B = -30 \text{ mA}$		-1.1	-1.5	V
Transition frequency		$f_T$	$V_{CB} = -10 \text{ V}, I_E = 50 \text{ mA}, f = 200 \text{ MHz}$		200		MHz
Collector output capacitance		C <sub>ob</sub>	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		6	15	pF
(Common base, input open circuited)							

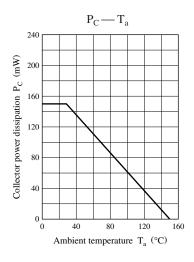
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

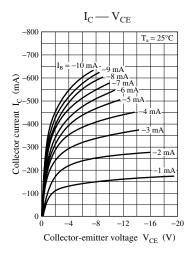
#### 2. \*1: Pulse measurement

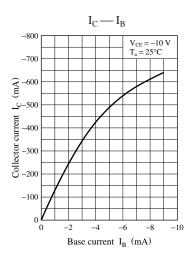
#### \*2: Rank classification

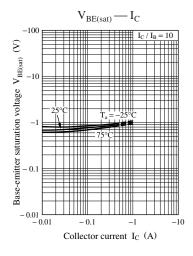
Ra	ank	Q	R	S	No-rank
h	FE1	85 to 170	120 to 240	170 to 340	85 to 340
Marking	2SB1219	CQ	CR	CS	С
symbol	2SB1219A	DQ	DR	DS	D

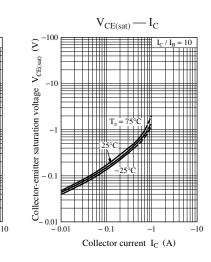
Note) Product of no-rank is not classified and have no marking symbol for rank.

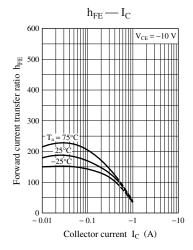


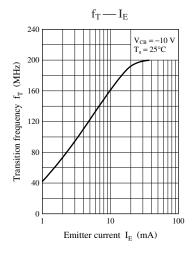


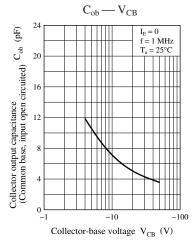


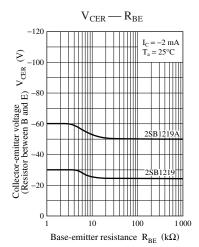












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